

<b>Notice of References Cited</b>	Application/Control No. 10/645,868		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner CHRISTOPHER R. LAMB		Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0031069	03-2002	Nakane et al.	369/53.15
*	B	US-6,714,493	03-2004	Kishimoto et al.	369/44.38
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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